

## Alternate estimators for $H$

### The $m(q, \Delta)$ estimator from [GJR18]

For the first task, let  $SS_n^{(q)} := \frac{1}{n} \sum_{i=1}^n |B_{i\Delta}^H - B_{(i-1)\Delta}^H|^q$ . Then

$$\mathbb{E}(SS_n^{(q)}) = \frac{1}{n} \mathbb{E}(\sum_{i=1}^n |B_{i\Delta}^H - B_{(i-1)\Delta}^H|^q) = \Delta^{qH} \frac{1}{n} \sum_{i=1}^n \mathbb{E}(|B_i^H - B_{i-1}^H|^q) = \mathbb{E}(|Z|^q) \Delta^{qH} = K_q \Delta^{qH} \quad (1)$$

where  $K_q = \mathbb{E}(|Z|^q) = \frac{2^{q/2}}{\sqrt{\pi}} \Gamma(\frac{q+1}{2})$ , with  $q > -1$  and  $Z \sim N(0, 1)$ . From this we can then derive the estimator for the first task. Alternatively, if let  $X = \sigma B_t^H$  and now define  $SS_n^{(q)} = \frac{1}{n} \mathbb{E}(\sum_{i=1}^n |X_{i\Delta}^H - X_{(i-1)\Delta}^H|^q)$ , and assume  $H$  and  $\sigma$  are unknown, then (1) changes to

$$\mathbb{E}(SS_n^{(q)}) = \sigma^q K_q \Delta^{qH}$$

which leads to the estimate

$$SS_n^{(q)} = \hat{\sigma}^q K_q \Delta^{q\hat{H}}.$$

for  $H$  and  $\sigma$ . Taking logs we see that

$$\log SS_n^{(q)} = q \log \hat{\sigma} + \log K_q + q\hat{H} \log \Delta$$

so we can perform **linear regression** on  $\log SS_n^{(q)}$  vs  $\log \Delta$  for a range of  $\Delta$ -values (i.e. using a log-log plot). Then for the line of best fit, the **slope** will equal  $q\hat{H}$  ( $q$  is chosen by you, e.g.  $q = 1, 2, 2.5, 3$  etc), and the **intercept** at  $\log \Delta = 0$  is  $q \log \hat{\sigma} + \log K_q$ , from which we can compute  $\hat{\sigma}$  since  $K_q$  has an explicit formula above.

This is the  $m(q, \Delta)$  estimator discussed in [GJR18]. One can then also compute the  $R^2$ -**statistic** for the regression (which measures how close the data is to the line of best fit), and try to estimate the **sample variance** of  $\hat{H}$  and  $\hat{\sigma}$ .

### The Han-Schied [HS21] estimator

Let  $X_t = \sigma B_t^H$  and let

$$\theta_{m,k} = 2^{\frac{m}{2}} (2X_{\frac{2k+1}{2^{m+1}}} - X_{\frac{k}{2^m}} - X_{\frac{k+1}{2^m}}) = -2^{\frac{m}{2}} (X_{\frac{2(k+1)}{2^{m+1}}} - 2X_{\frac{2k+1}{2^{m+1}}} - X_{\frac{2k}{2^{m+1}}})$$

(note the similarity of the second expression to a 2nd order finite difference estimate). Then (with some tedious algebra) using the formula for  $R(s, t) = \mathbb{E}(B_s^H B_t^H)$ , one can check that

$$\mathbb{E}(\theta_{m,k}^2) = \sigma^2 2^{m-2H(1+m)} (4 - 4^H). \quad (2)$$

Then setting  $s_n^2 = \sum_{m=0}^{n-1} \sum_{k=0}^{2^m-1} \theta_{m,k}^2$ , we see that  $\mathbb{E}(s_n^2) = \sum_{m=0}^{n-1} 2^m \mathbb{E}(\theta_{m,k}^2)$  (since (2) does not depend on  $k$ ) which simplifies to

$$\mathbb{E}(s_n^2) = \sigma^2 (4^{n(1-H)} - 1) \sim \sigma^2 4^{n(1-H)} = \sigma^2 2^{2n(1-H)}$$

as  $n \rightarrow \infty$ , which suggests an estimator  $\hat{H}$  defined by

$$s_n = \hat{\sigma} 2^{n(1-\hat{H})}$$

which (assuming  $\hat{\sigma} = O(1)$  as  $n \rightarrow \infty$ ) we can re-arrange as

$$\hat{H} = 1 - \frac{1}{n} \log_2 \left( \frac{s_n}{\hat{\sigma}} \right) = 1 - \frac{1}{n} \log_2 s_n + O\left(\frac{1}{n}\right)$$

where  $\log_2$  denotes the base-2 logarithm, so (ignoring the  $O(\frac{1}{n})$  remainder term), we recover the Han-Schied[HS21] estimator  $\hat{H} = 1 - \frac{1}{n} \log_2 s_n$  (which in principle also works for general processes which aren't fBM if  $n$  is sufficiently large).

Or we can jointly estimate  $H$  and  $\sigma$  by performing linear regression since

$$\log s_n = \log \hat{\sigma} + n(1 - \hat{H}) \log 2$$

but we now have to compute  $\log s_n$  for a range of different  $n$ -values to get a line of best fit, for which the slope is  $(1 - \hat{H}) \log 2$  and the intercept is  $\log \hat{\sigma}$ .

You can then draw histograms of  $\hat{H}$  if you simulate  $M$  fBM paths and compute the sample variance for  $\hat{H}$  (or a confidence interval), or compute  $\hat{H}$  for real data, e.g. using the SPX data file or data from yahoo finance.

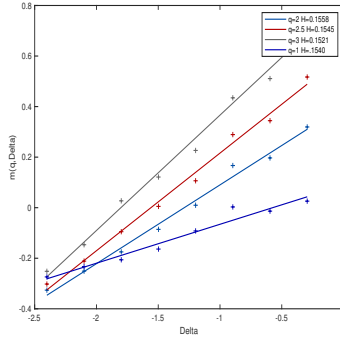


Figure 1: Estimates of  $H$  using the  $m(q, \Delta)$  method using Oxford Mann data from 2000-2018 (see similar plots in [GJR18]).

## Discussion on the rough Heston model, and the Riemann-Liouville process

The driftless rough Heston model satisfies

$$V_t = V_0 + \nu \int_0^t (t-u)^{H-\frac{1}{2}} \sqrt{V_u} dW_u.$$

Then  $\mathbb{E}(V_t) = V_0$ , and  $V$  has covariance function:

$$\begin{aligned} \mathbb{E}((V_s - V_0)(V_t - V_0)) &= \nu^2 \mathbb{E}\left(\int_0^s (s-u)^{H-\frac{1}{2}} \sqrt{V_u} dW_u \cdot \int_0^t (t-r)^{H-\frac{1}{2}} \sqrt{V_r} dW_r\right) \\ &= \nu^2 \int_0^s (s-u)^{H-\frac{1}{2}} (t-u)^{H-\frac{1}{2}} \mathbb{E}(V_u) du \\ &= \nu^2 V_0 \int_0^s (s-u)^{H-\frac{1}{2}} (t-u)^{H-\frac{1}{2}} du = V_0 \nu^2 \bar{R}(s, t) \end{aligned}$$

for  $0 \leq s \leq t$ , where  $\bar{R}(s, t)$  is the covariance function for the Riemann-Liouville (RL) process  $Z_t = \int_0^t (t-u)^{H-\frac{1}{2}} dW_u$  used for the rough Bergomi model, (note  $Z$  is a Gaussian process but  $V$  is not), but the explicit formula for  $\bar{R}(s, t)$  is more complicated than the  $R(s, t)$  formula for fBM.

We also have the **Mandelbrot-van Ness** representation for fBM:

$$W_t^H = c_H \left( \int_{-\infty}^0 ((t-s)^{H-\frac{1}{2}} - (-s)^{H-\frac{1}{2}}) dW_s + \int_0^t (t-s)^{H-\frac{1}{2}} dW_s \right) = c_H (A_t + Z_t)$$

in terms of the RL process  $Z$  above (and note that  $A_t$  is known at time zero for all  $t \geq 0$ ), and  $c_H = \left( \frac{2H \Gamma(\frac{3}{2}-H)}{\Gamma(H+\frac{1}{2}) \Gamma(2-2H)} \right)^{\frac{1}{2}}$ .

## References

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